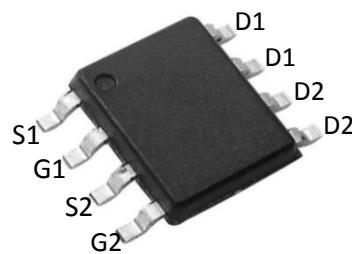


Description:

This N+P Channel MOSFET uses advanced trench technology and design to provide excellent RDS(on) with low gate charge. It can be used in a wide variety of applications.



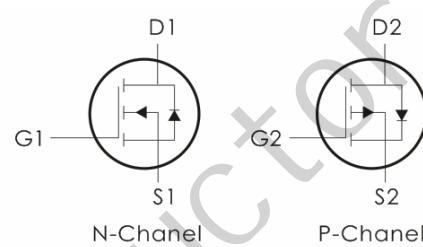
Features:

N-Channel: $V_{DS}=40V, I_D=8A, R_{DS(ON)}<22m\Omega @ V_{GS}=10V$

P-Channel: $V_{DS}=-40V, I_D=-6A, R_{DS(ON)}<53m\Omega @ V_{GS}=-10V$

1)

- 2) Low gate charge.
- 3) Green device available.
- 4) Advanced high cell density trench technology for ultra low $R_{DS(ON)}$.
- 5) Excellent package for good heat dissipation.



Absolute Maximum Ratings: ($T_A=25^\circ C$ unless otherwise noted)

Symbol	Parameter	N-Channel	P-Channel	Units
V_{DS}	Drain-Source Voltage	40	-40	V
V_{GS}	Gate-Source Voltage	± 20	± 20	V
I_D	Continuous Drain Current- $T_A=25^\circ C$	8	-6	A
	Continuous Drain Current- $T_A=100^\circ C$	5.2	-3.9	
I_{DM}	Pulsed Drain Current ^{note1}	32	-24	A
E_{AS}	Single Pulsed Avalanche Energy ^{note2}	13	17.6	mJ
P_D	Power Dissipation - $T_A=25^\circ C$	2.0	3.2	W
T_J, T_{STG}	Operating and Storage Junction Temperature Range	-55 to +150		°C

Thermal Characteristics:

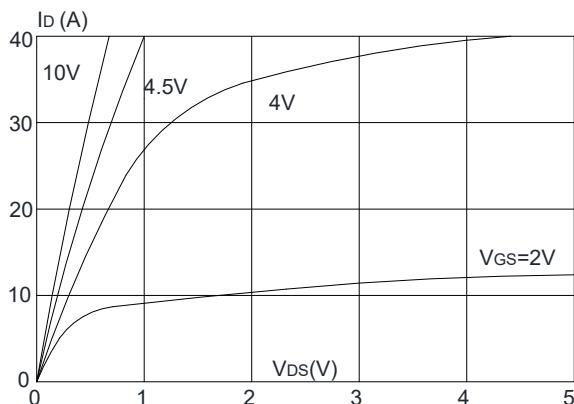
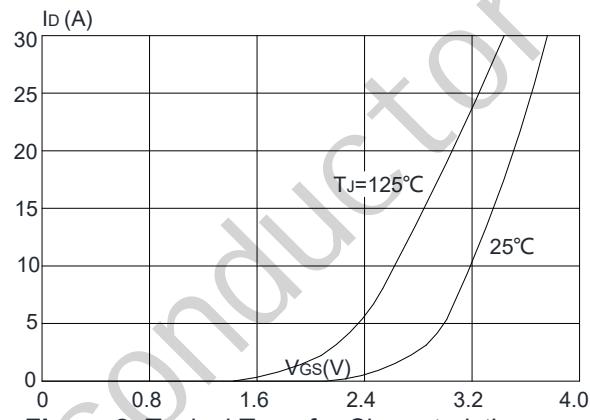
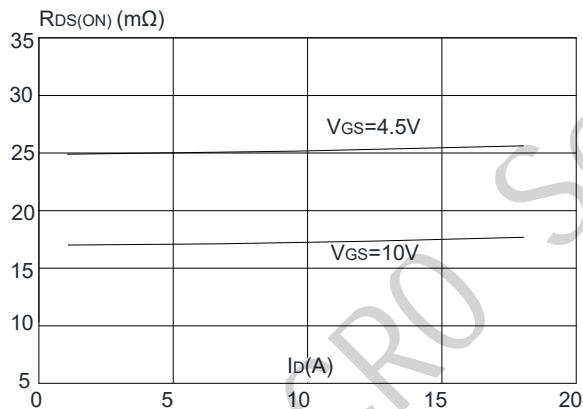
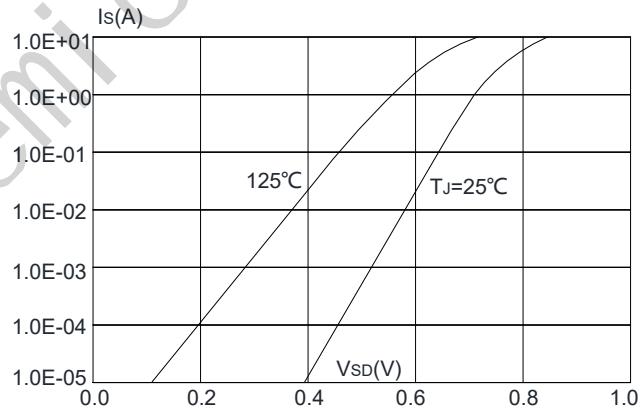
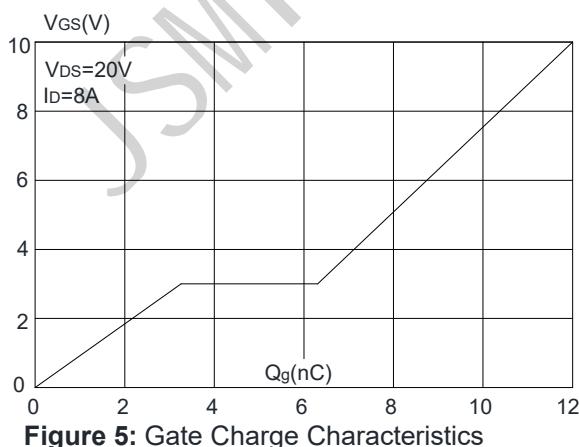
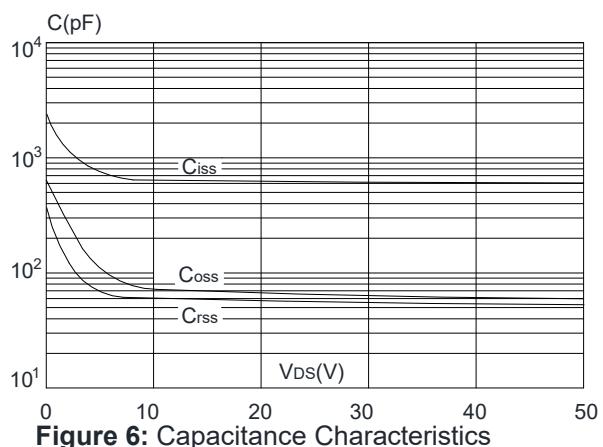
Symbol	Parameter	N-CH	P-CH	Units
$R_{\theta JA}$	Thermal Resistance,Junction to Ambient	62.5	39	°C/W

N-Channel Electrical Characteristics: (T_J=25°C unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
Off Characteristics						
BV_{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _D =250 μA	40	---	---	V
I_{DSS}	Zero Gate Voltage Drain Current	V _{GS} =0V, V _{DS} =40V	---	---	1	μA
I_{GSS}	Gate-Source Leakage Current	V _{GS} =±20V, V _{DS} =0A	---	---	±100	nA
On Characteristics³						
V_{GS(th)}	GATE-Source Threshold Voltage	V _{GS} =V _{DS} , I _D =250 μA	1	1.5	2.5	V
R_{DS(ON)}	Drain-Source On Resistance ^{note3}	V _{GS} =10V, I _D =8A	---	17	22	mΩ
		V _{GS} =4.5V, I _D =5A	---	25	35	
Dynamic Characteristics⁴						
C_{iss}	Input Capacitance	V _{DS} =20V, V _{GS} =0V, f=1MHz	---	620	---	pF
C_{oss}	Output Capacitance		---	65	---	
C_{rss}	Reverse Transfer Capacitance		---	55	---	
Q_g	Gate Charge	V _{GS} =8V V _{DS} =20V I _D =10A		12	---	nc
Q_{gs}	Gate-Source Charge			3.2	---	
Q_{gd}	Gate-Drain Charge			3.1	---	
Switching Characteristics⁴						
t_{d(on)}	Turn-On Delay Time	V _{DS} =20V, R _L =2.5Ω, R _{REN} =3Ω, V _{GS} =10V	---	4	---	ns
t_r	Rise Time		---	3	---	ns
t_{d(off)}	Turn-Off Delay Time		---	15	---	ns
t_f	Fall Time		---	2	---	ns
Drain-Source Diode Characteristics						
I_S	Continuous Drain to Source Diode	---	---	---	8	A
I_{SM}	Pulsed Drain to Source Diode	---	---	---	32	A
V_{SD}	Source-Drain Diode Forward Voltage	V _{GS} =0V, I _S =8A	---	---	1.2	V

Notes:

1. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature
2. EAS condition : $T_J=25^\circ\text{C}$, $V_{DD}=20\text{V}$, $V_G=10\text{V}$, $L=0.5\text{mH}$, $R_g=25\Omega$, $I_{AS}=7.2\text{A}$
 $T_J=25^\circ\text{C}$, $V_{DD}=-20\text{V}$, $V_G= -10\text{V}$, $L=0.5\text{mH}$, $R_g=25\Omega$, $I_{AS}=-8.4\text{A}$
3. Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$

Typical Performance Characteristics-N

Figure 1: Output Characteristics

Figure 2: Typical Transfer Characteristics

Figure 3: On-resistance vs. Drain Current

Figure 4: Body Diode Characteristics

Figure 5: Gate Charge Characteristics

Figure 6: Capacitance Characteristics

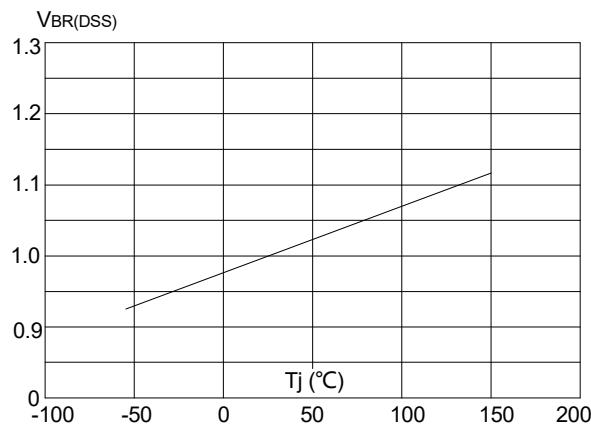


Figure 7: Normalized Breakdown Voltage vs. Junction Temperature

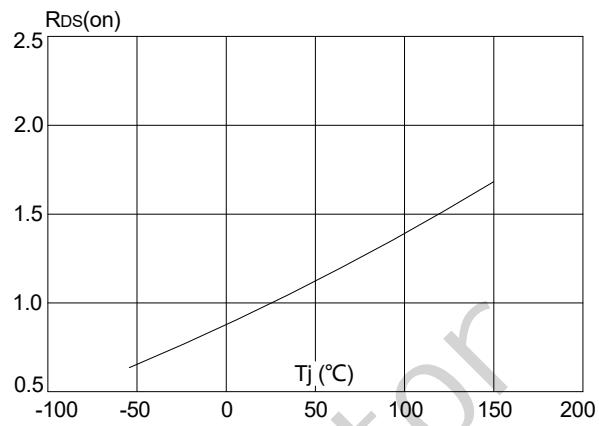


Figure 8: Normalized on Resistance vs. Junction Temperature

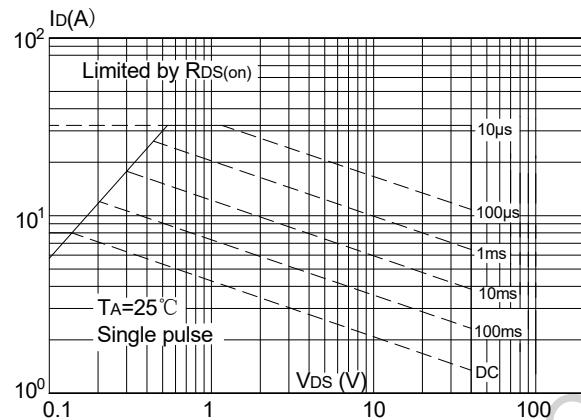


Figure 9: Maximum Safe Operating Area

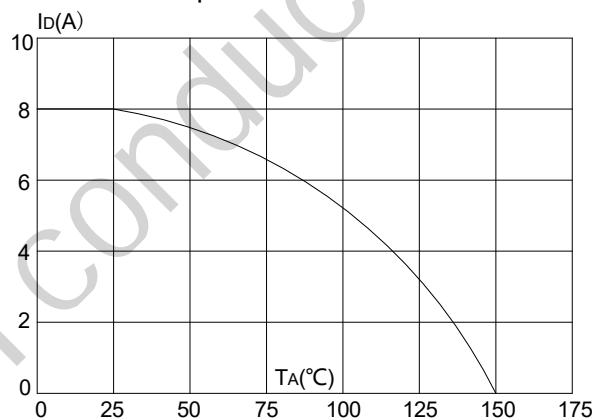


Figure 10: Maximum Continuous Drain Current vs. Ambient Temperature

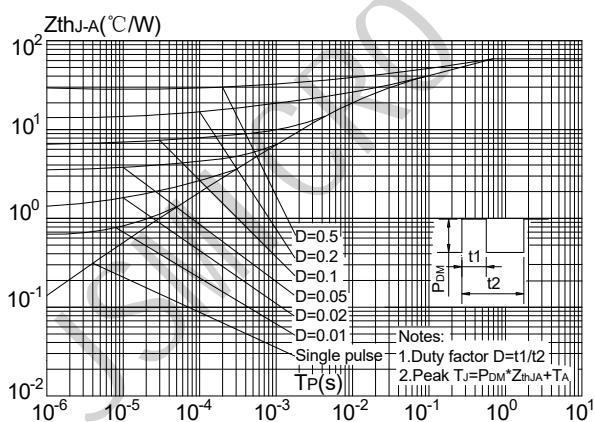


Figure 11: Maximum Effective Transient Thermal Impedance, Junction-to-Ambient

P-Channel Electrical Characteristics: ($T_J=25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
Off Characteristics						
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{\text{GS}}=0\text{V}, I_{\text{D}}=250 \mu\text{A}$	-40	---	---	V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{\text{GS}}=0\text{V}, V_{\text{DS}}=-40\text{V}$	---	---	-1	μA
I_{GSS}	Gate-Source Leakage Current	$V_{\text{GS}}=\pm 20\text{V}, V_{\text{DS}}=0\text{A}$	---	---	± 100	nA
On Characteristics³						
$V_{\text{GS}(\text{th})}$	GATE-Source Threshold Voltage	$V_{\text{GS}}=V_{\text{DS}}, I_{\text{D}}=250 \mu\text{A}$	-1	-1.6	-2.5	V
$R_{\text{DS}(\text{ON})}$	Drain-Source On Resistance ^{note3}	$V_{\text{GS}}=-10\text{V}, I_{\text{D}}=-6\text{A}$	---	41	53	$\text{m}\Omega$
		$V_{\text{GS}}=-4.5\text{V}, I_{\text{D}}=-4\text{A}$	---	58	81	
Dynamic Characteristics						
C_{iss}	Input Capacitance	$V_{\text{DS}}=-20\text{V}, V_{\text{GS}}=0\text{V}, f=1\text{MHz}$	---	850	---	pF
C_{oss}	Output Capacitance		---	85	---	
C_{rss}	Reverse Transfer Capacitance		---	68	---	
Switching Characteristics⁴						
$t_{\text{d(on)}}$	Turn-On Delay Time	$V_{\text{DD}}= -20\text{V}, R_{\text{L}}=2.3 \Omega$	---	7.5	---	ns
t_r	Rise Time		---	5.5	---	ns
$t_{\text{d(off)}}$	Turn-Off Delay Time		---	19	---	ns
t_f	Fall Time		---	7	---	ns
Q_g	Total Gate Charge	$V_{\text{GS}}= -10\text{V}, R_{\text{GEN}}=6 \Omega$	---	13	---	nC
Q_{gs}	Gate-Source Charge		---	3.8	---	nC
Q_{gd}	Gate-Drain "Miller" Charge		---	3.1	---	nC
Drain-Source Diode Characteristics						
I_s	Continuous Drain to Source Diode	---	---	---	-6	A
I_{SM}	Pulsed Drain to Source Diode	---	---	---	-24	---
V_{SD}	Source-Drain Diode Forward Voltage	$V_{\text{GS}}=0\text{V}, I_{\text{S}}=-6\text{A}$	---	---	-1.2	V

Typical Performance Characteristics-P

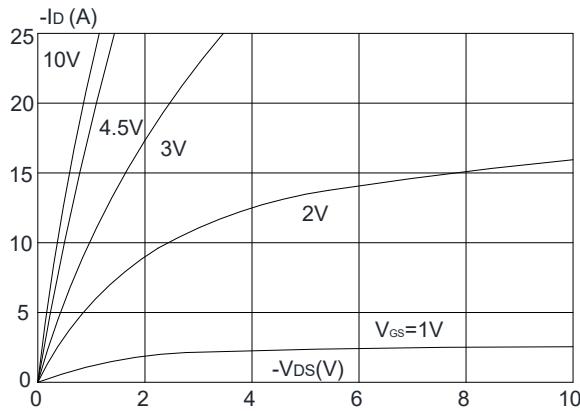


Figure 1: Output Characteristics

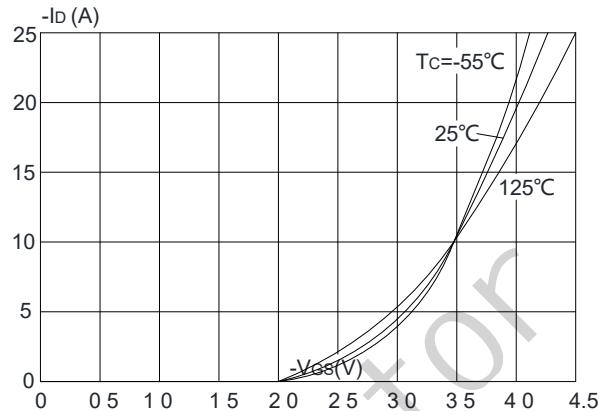


Figure 2: Typical Transfer Characteristics

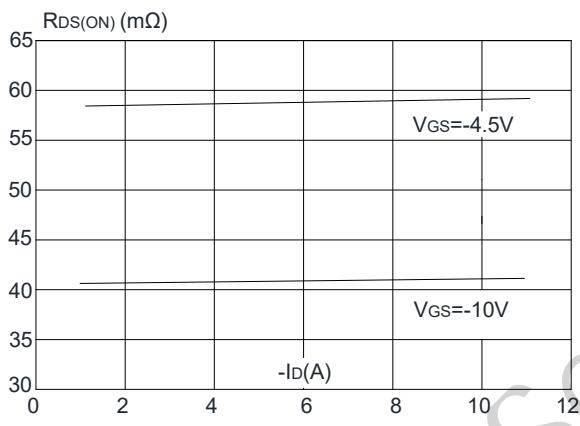


Figure 3: On-resistance vs. Drain Current

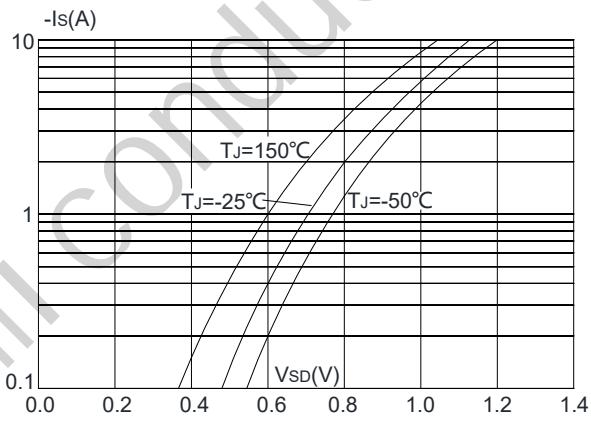


Figure 4: Body Diode Characteristics

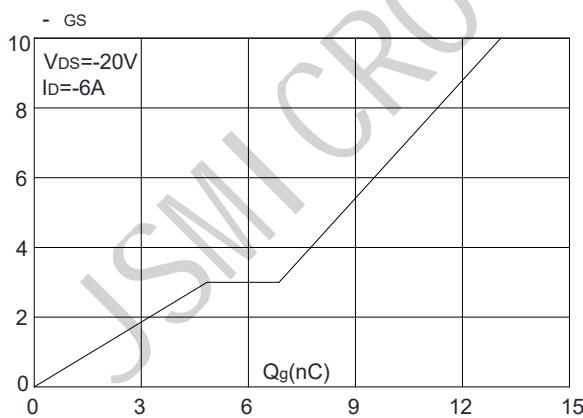


Figure 5: Gate Charge Characteristics

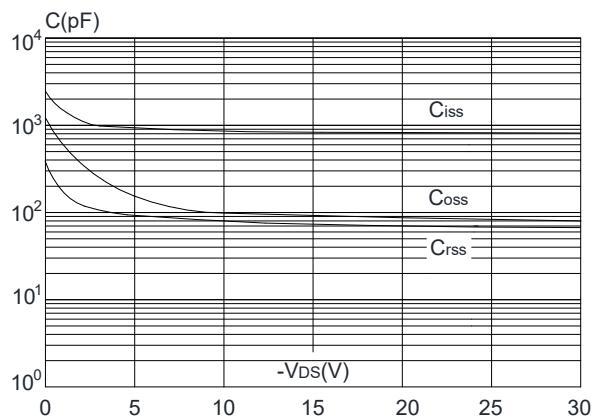


Figure 6: Capacitance Characteristics

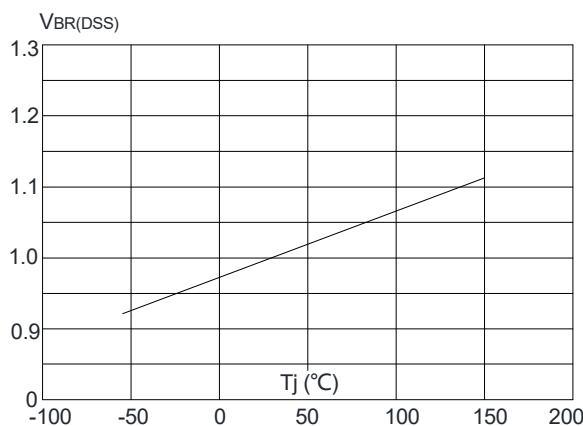


Figure 7: Normalized Breakdown Voltage vs. Junction Temperature

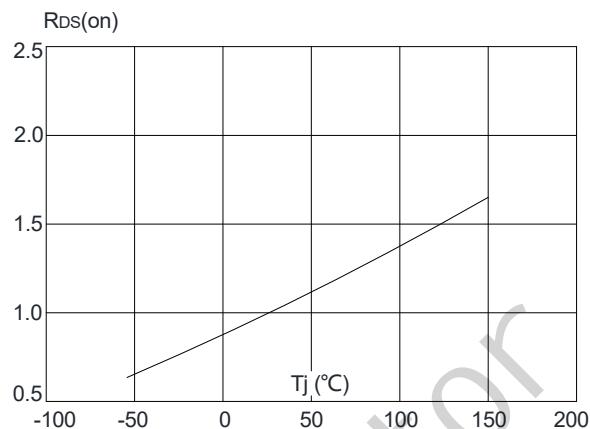


Figure 8: Normalized on Resistance vs. Junction Temperature

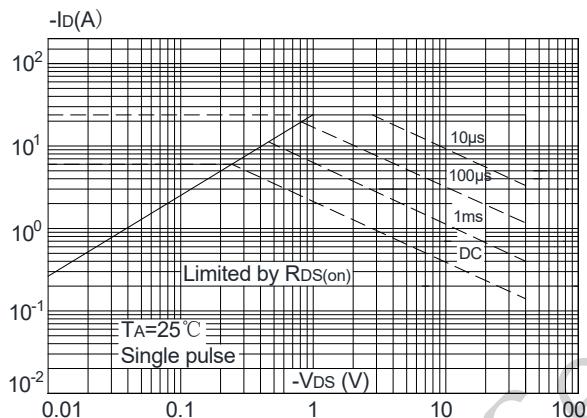


Figure 9: Maximum Safe Operating Area

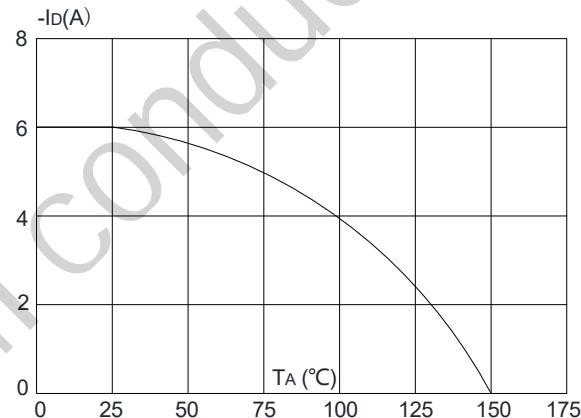


Figure 10: Maximum Continuous Drain Current vs. Ambient Temperature

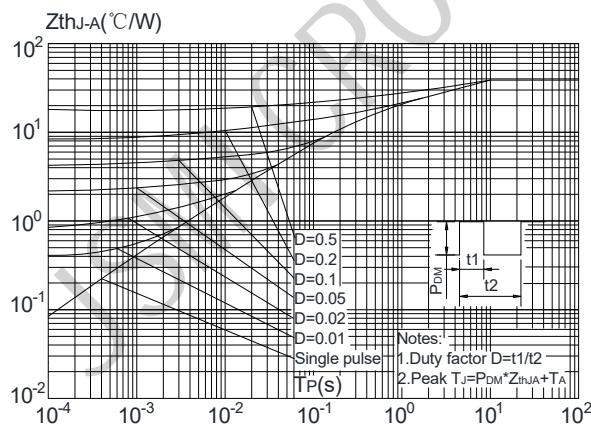
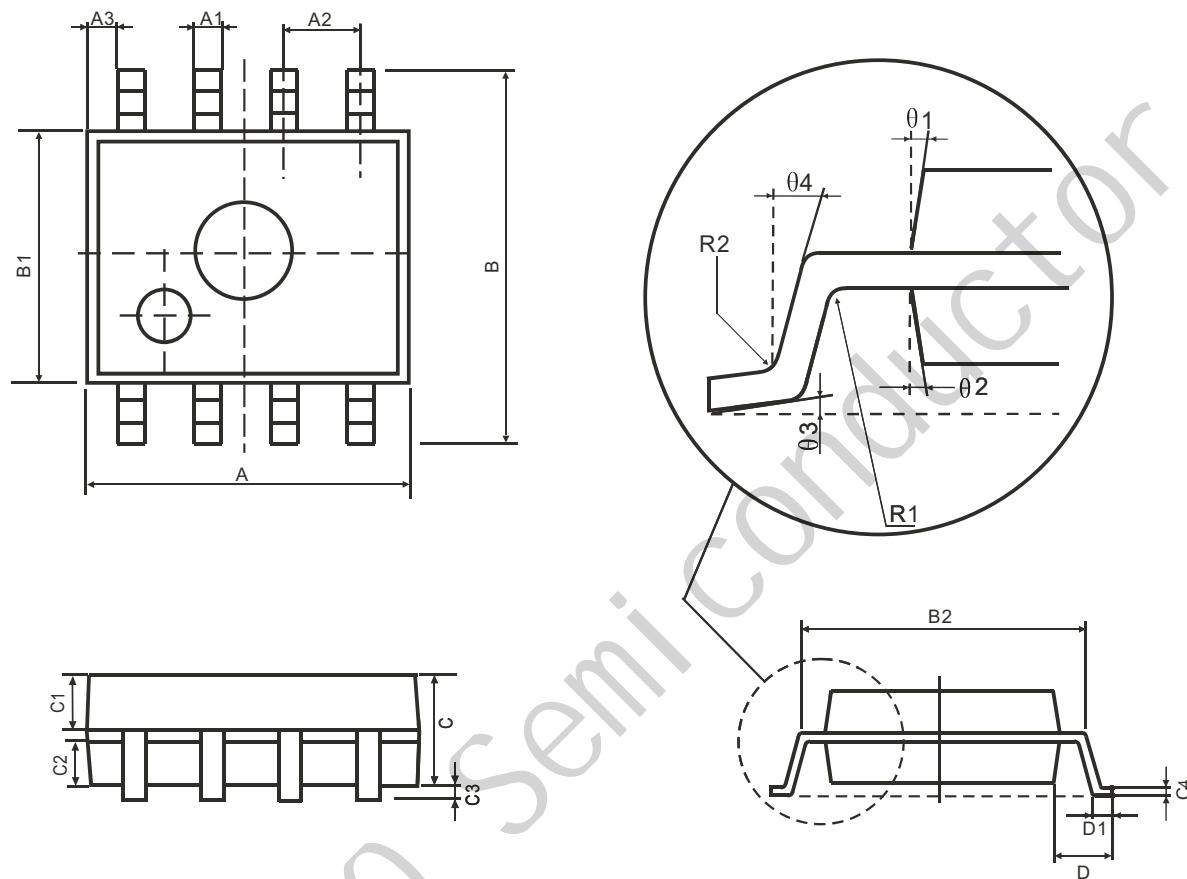


Figure 11: Maximum Effective Transient Thermal Impedance, Junction-to-Ambient

外形尺寸图 / Package Dimensions

SOP-8

Dimensions in mm



符号	尺寸(mm)		符号	尺寸(mm)	
	最小值	最大值		最小值	最大值
A	4.95	5.15	C3	0.05	0.20
A1	0.37	0.47	C4	0.20(典型值)	
A2	1.27(典型值)		D	1.05(典型值)	
A3	0.41(典型值)		D1	0.40	0.60
B	5.80	6.20	R1	0.07(典型值)	
B1	3.80	4.00	R2	0.07(典型值)	
B2	5.0(典型值)		θ1	17°(典型值)	
C	1.30	1.50	θ2	13°(典型值)	
C1	0.55	0.65	θ3	4°(典型值)	
C2	0.55	0.65	θ4	12°(典型值)	

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